

TENTATIVE

FM400TU-2A

HIGH POWER SWITCHING USE

ELECTRICAL CHARACTERISTICS ($T_{ch} = 25\text{ }^{\circ}\text{C}$)

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit	
I_{DSS}	Drain cutoff current	$V_{DS}=V_{DSS}, V_{GS}=0V$	—	—	1	mA	
$V_{GS(th)}$	Gate-source threshold voltage	$I_D=20mA, V_{DS}=10V$	4.7	6	7.3	V	
I_{GSS}	Gate leakage current	$V_{GS}=V_{GSS}, V_{DS}=0V$	—	—	1.5	μA	
$r_{DS(ON)}$ (chip)	Static drain-source On-state resistance	$I_D=200A$ $V_{GS}=15V$	$T_{ch}=25\text{ }^{\circ}\text{C}$	—	1.45	2.0	m Ω
			$T_{ch}=125\text{ }^{\circ}\text{C}$	—	2.5	—	
$V_{DS(ON)}$ (chip)	Static drain-source On-state voltage	$I_D=200A$ $V_{GS}=15V$	$T_{ch}=25\text{ }^{\circ}\text{C}$	—	0.29	0.40	V
			$T_{ch}=125\text{ }^{\circ}\text{C}$	—	0.50	—	
$R_{(lead)}$	lead resistance	$I_D=200A$ terminal-chip	$T_{ch}=25\text{ }^{\circ}\text{C}$	—	0.8	—	m Ω
			$T_{ch}=125\text{ }^{\circ}\text{C}$	—	1.12	—	
C_{iss}	Input capacitance	$V_{DS}=10V$ $V_{GS}=0V$	—	—	75	nF	
C_{oss}	Output capacitance		—	—	10		
C_{rSS}	Reverse transfer capacitance		—	—	6		
Q_G	Total gate charge	$V_{DD}=48V, I_D=200A, V_{GS}=15V$	—	1200	—	nC	
$t_{d(on)}$	Turn-on delay time	$V_{DD}=48V, I_D=200A$ $V_{GS1}=V_{GS2}=15V$ $R_G=6.3\Omega$, Inductive load switching operation	—	—	400	ns	
t_r	Turn-on rise time		—	—	400		
$t_{d(off)}$	Turn-off delay time		—	—	450		
t_f	Turn-off fall time		—	—	300		
t_{rr} ①	Reverse recovery time		$I_S=200A$	—	—		250
Q_{rr} ①	Reverse recovery charge		—	6.0	—	μC	
V_{SD} ①	Source-drain voltage	$I_S=200A, V_{GS}=0V$	—	—	1.3	V	
$R_{th(ch-c)}$	Thermal resistance	MOSFET part(1/6 module)	—	—	0.19	$^{\circ}\text{C/W}$	
$R_{th(ch-c)}$		MOSFET part(1/6 module)	—	—	0.142 ^{*1}		
$R_{th(c-f)}$	Contact thermal resistance	Case to fin, Thermal compound Applied ^{*2} (1/6 module)	—	0.1	—		

Thermistors part

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
R_{TH} ④	Resistance	$T_C=25^{\circ}\text{C}$	—	100	—	k Ω
B ④	B Constant	Resistance at $25^{\circ}\text{C}, 50^{\circ}\text{C}$	—	4000	—	K

① I_S, V_{SD}, t_{rr} & Q_{rr} represent characteristics of the anti-parallel, source to drain free-wheel diode(FWD).

② Pulse width and repetition rate should be such that the device channel temp. (T_{ch}) does not exceed T_{ch} max rating.

③ Channel temperature (T_{ch}) should not increase beyond 150°C .

④ $B = (\ln R_1 - \ln R_2) / (1/T_1 - 1/T_2)$ R_1 : Resistance at $T_1(K)$, R_2 : Resistance at $T_2(K)$

*1: T_c measured point is just under the chips. If you use this value, $R_{th}(f-a)$ should be measured just under the chips.

*2: Typical value is measured by using Shin-etsu Silicone "G-746".

*3: T_c measured point is shown in page "3-3".

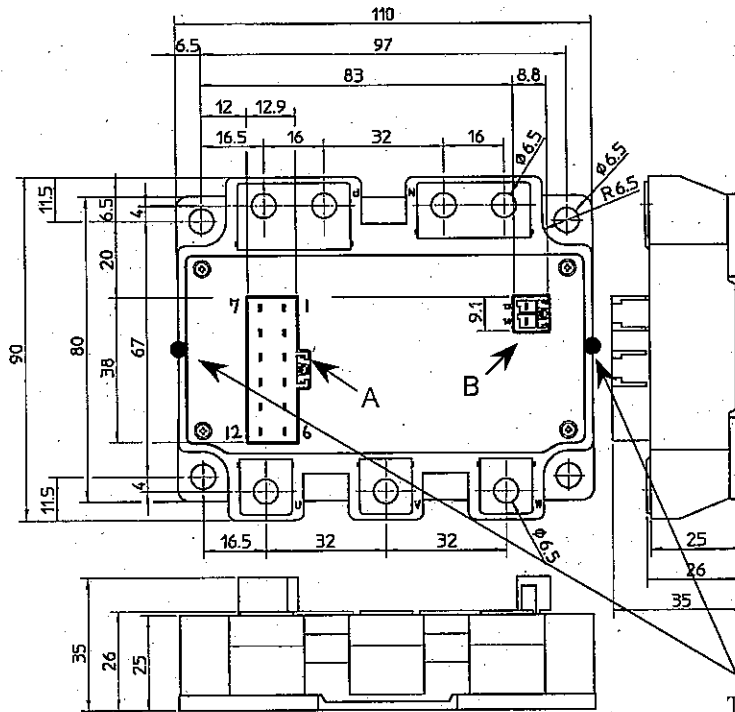
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OUTLINE DRAWING

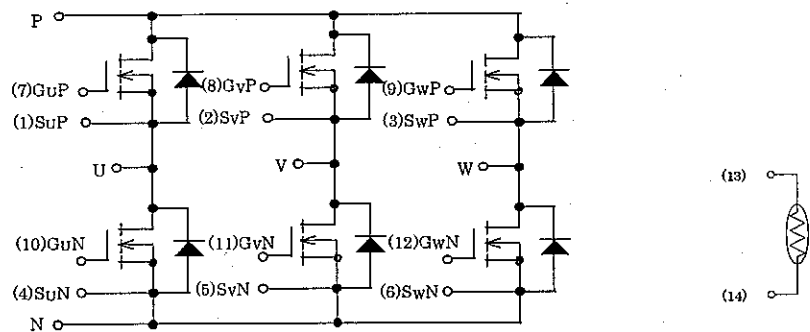
Dimensions in mm



Tc measured point

Housing Type of A and B
(Tyco Electronics P/N:)
A: 917353-1
B: 179838-1

CIRCUIT DIAGRAM



(1) S _{UP}	(2) S _{VP}	(3) S _{WP}	(4) S _{UN}	(5) S _{VN}	(6) S _{WN}	A
(7) G _{UP}	(8) G _{VP}	(9) G _{WP}	(10) G _{UN}	(11) G _{VN}	(12) G _{WN}	
(13) TH1	(14) TH2					B